BFU668F

NPN wideband silicon RF transistor

Rev. 3 — 24 January 2012

Product data sheet

1. Product profile

1.1 General description

NPN silicon microwave transistor in a plastic, 4-pin dual-emitter SOT343F package offering an innovative Ku-band DRO solution.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

1.2 Features and benefits

- DROs with good output power and low phase noise at very low current consumption: 5 dBm and -55 dBc/Hz/1 kHz at 12 mA
- Low-noise, high gain for low cost LNA solutions
- 40 GHz f_T silicon technology

1.3 Applications

- Ku-band DROs in Ku-band LNBs
- C-band, low current LNAs



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1.4 Quick reference data

Table 1. Quick reference data

| Table 1. | Quick reference data | | | | | | |
|-----------------------|--|--|-----|-----|------|-----|------|
| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
| V_{CBO} | collector-base voltage | open emitter | | - | - | 16 | V |
| V_{CEO} | collector-emitter voltage | open base | | - | - | 5.5 | V |
| V_{EBO} | emitter-base voltage | open collector | | - | - | 2.5 | V |
| I _C | collector current | | | - | 15 | 40 | mΑ |
| P_{tot} | total power dissipation | $T_{sp} \le 90 ^{\circ}C$ | [1] | - | - | 200 | mW |
| h _{FE} | DC current gain | $I_C = 10 \text{ mA}; V_{CE} = 3.5 \text{ V};$ $T_j = 25 ^{\circ}\text{C}$ | | 90 | 135 | 200 | |
| C_{CBS} | collector-base capacitance | $V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$ | | - | 138 | - | fF |
| f _T | transition frequency | I_C = 15 mA; V_{CE} = 3.5 V; f = 2 GHz; T_{amb} = 25 °C | | - | 20 | - | GHz |
| IP3 _{o(max)} | maximum output third-order intercept point | I_{C} = 15 mA; V_{CE} = 3.5 V; f = 10 GHz; T_{amb} = 25 °C; Z_{S} = Z_{L} = 50 Ω ; | | - | 24 | - | dBm |
| G _{p(max)} | maximum power gain | I_{C} = 15 mA; V_{CE} = 3.5 V; f = 10.0 GHz; T_{amb} = 25 °C | [2] | - | 10.5 | - | dB |
| NF | noise figure | $\begin{split} &I_{C} = 15 \text{ mA; } V_{CE} = 3.5 \text{ V;} \\ &f = 10.0 \text{ GHz; } \Gamma_{S} = \Gamma_{opt}; \\ &T_{amb} = 25 \text{ °C} \end{split}$ | | - | 1.7 | - | dB |
| P _{L(1dB)} | output power at 1 dB gain compression | I_{C} = 15 mA; V_{CE} = 3.5 V; Z_{S} = Z_{L} = 50 Ω ; f = 10 GHz; T_{amb} = 25 °C | | - | 12 | - | dBm |
| | | | | | | | |

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

2. Pinning information

Table 2. Discrete pinning

| Table 2. | Discrete piliting | | |
|----------|-------------------|--------------------|----------------|
| Pin | Description | Simplified outline | Graphic symbol |
| 1 | emitter | | |
| 2 | base | 3 4 | 4 |
| 3 | emitter | | 2 — |
| 4 | collector | | 1, 3 |
| | | 2 1 | mbb159 |

^[2] $G_{p(max)}$ is the maximum power gain, if K > 1. If K < 1 then $G_{p(max)} = MSG$.

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3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|-------------|---------|---|---------|
| | Name | Description | Version |
| BFU668F | - | plastic surface-mounted flat pack package; reverse pinning; 4 leads | SOT343F |

4. Marking

Table 4. Marking

| Type number | Marking | Description |
|-------------|---------|--------------------------|
| BFU668F | ZA* | * = p: made in Hong Kong |
| | | * = t : made in Malaysia |
| | | * = w : made in China |

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SymbolParameterConditionsMinMaxUVCBOcollector-base voltageopen emitter-16VVCEOcollector-emitter voltageopen base-5.5V | |
|---|------|
| | Jnit |
| V _{CEO} collector-emitter voltage open base - 5.5 V | / |
| | / |
| V _{EBO} emitter-base voltage open collector - 2.5 V | / |
| I _C collector current - 40 m | nΑ |
| P_{tot} total power dissipation $T_{sp} \le 90 ^{\circ}\text{C}$ [1] - 200 m | nW |
| T _{stg} storage temperature –65 +150 °C | C |
| T _j junction temperature - 150 °C | C |

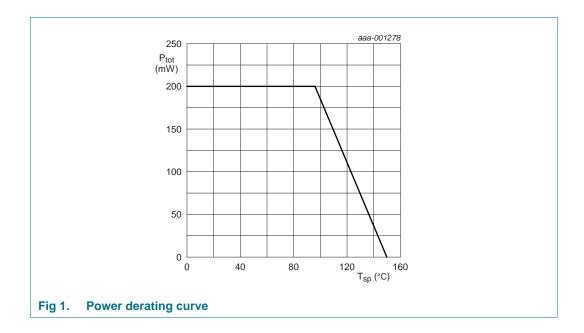
^[1] T_{sp} is the temperature at the solder point of the emitter lead.

6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Тур | Unit |
|----------------|--|------------|-----|------|
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | | 270 | K/W |

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7. Characteristics

Table 7. Characteristics

 $T_i = 25$ °C unless otherwise specified

| , | • | | | | | |
|-----------------------|--|--|-----|------|-----|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5 \mu A; I_E = 0 \text{ mA}$ | 16 | - | - | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 1 \text{ mA}; I_B = 0 \text{ mA}$ | 5.5 | - | - | V |
| I _C | collector current | | - | 15 | 40 | mΑ |
| I _{CBO} | collector-base cut-off current | $I_E = 0 \text{ mA}; V_{CB} = 8 \text{ V}$ | - | - | 100 | nA |
| h _{FE} | DC current gain | $I_C = 10 \text{ mA}; V_{CE} = 3.5 \text{ V}$ | 90 | 135 | 200 | |
| C _{CES} | collector-emitter capacitance | V _{CB} = 2 V; f = 1 MHz | - | 297 | - | fF |
| C _{EBS} | emitter-base capacitance | V _{EB} = 0.5 V; f = 1 MHz | - | 664 | - | fF |
| C _{CBS} | collector-base capacitance | V _{CB} = 2 V; f = 1 MHz | - | 138 | - | fF |
| f _T | transition frequency | I_C = 15 mA; V_{CE} = 3.5 V; f = 2 GHz; T_{amb} = 25 °C | - | 20 | - | GHz |
| G _{p(max)} | maximum power gain | I_C = 15 mA; V_{CE} = 3.5 V; T_{amb} = 25 °C | [1] | | | |
| | | f = 5.8 GHz | - | 14.5 | - | dB |
| | | f = 10.0 GHz | - | 10.5 | - | dB |
| $ s_{21} ^2$ | insertion power gain | I_C = 15 mA; V_{CE} = 3.5 V; T_{amb} = 25 °C | | | | |
| | | f = 5.8 GHz | - | 9.5 | - | dB |
| | | f = 10.0 GHz | - | 5.0 | - | dB |
| NF | noise figure | I_{C} = 15 mA; V_{CE} = 3.5 V; Γ_{S} = Γ_{opt} ; T_{amb} = 25 °C | | | | |
| | | f = 5.8 GHz | - | 1.3 | - | dB |
| | | f = 10.0 GHz | - | 1.7 | - | dB |
| G _{ass} | associated gain | I_{C} = 15 mA; V_{CE} = 3.5 V; Γ_{S} = Γ_{opt} ; T_{amb} = 25 °C | | | | |
| | | f = 5.8 GHz | - | 13 | - | dB |
| | | f = 10.0 GHz | - | 9.5 | - | dB |
| P _{L(1dB)} | output power at 1 dB gain compression | I_C = 15 mA; V_{CE} = 3.5 V; Z_S = Z_L = 50 Ω ; T_{amb} = 25 °C | | | | |
| | | f = 5.8 GHz | - | 13 | - | dBm |
| | | f = 10.0 GHz | - | 12 | - | dBm |
| IP3 _{o(max)} | maximum output third-order intercept point | I_C = 15 mA; V_{CE} = 3.5 V; Z_S = Z_L = 50 Ω ; T_{amb} = 25 °C | | | | |
| | | f = 5.8 GHz | - | 24 | - | dBm |
| | | f = 10.0 GHz | - | 24 | - | dBm |

^[1] $G_{p(max)}$ is the maximum power gain, if K > 1. If K < 1 then $G_{p(max)} = MSG$.

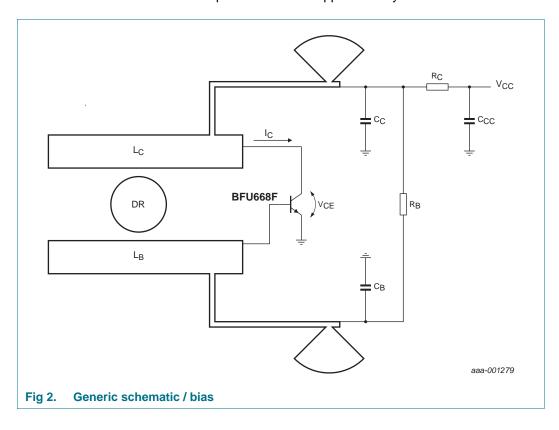
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8. Application information

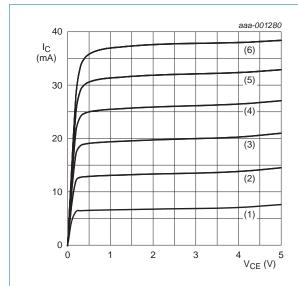
8.1 BFU668F Ku-band Dielectric Resonator Oscillator (DRO)

<u>Figure 2</u> shows a typical DRO circuit using BFU668F as active device. The schematic highlights the bias elements. Evaluation tests, done by replacing the existing transistor with BFU668F, on three different DRO LNBs / configurations, have proven:

- BFU668F achieves similar Phase Noise and RF power as the replaced transistor
- BFU668F achieves same RF performances at approximately half of the bias current



8.2 Graphs



 $T_{amb} = 25 \, ^{\circ}C.$

(1) $I_B = 50 \mu A$

(2) $I_B = 100 \mu A$

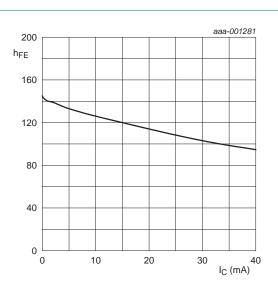
(3) $I_B = 150 \mu A$

(4) $I_B = 200 \mu A$

(5) $I_B = 250 \mu A$

(6) $I_B = 300 \mu A$

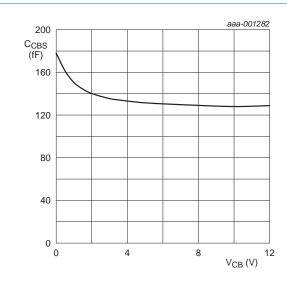
Fig 3. Collector current as a function of collector-emitter voltage; typical values



 V_{CE} = 2 V; T_{amb} = 25 °C.

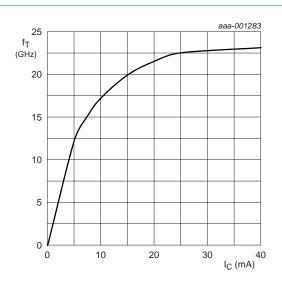
Fig 4. DC current gain as a function of collector current; typical values

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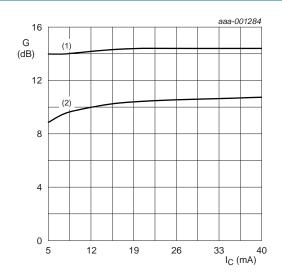
f = 1 MHz, $T_{amb} = 25$ °C.

Fig 5. Collector-base capacitance as a function of collector-base voltage; typical values



 V_{CE} = 3.5 V; f = 2 GHz; T_{amb} = 25 °C.

Fig 6. Transition frequency as a function of collector current; typical values



 $V_{CE} = 3.5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}.$

- (1) f = 5.8 GHz
- (2) f = 10.0 GHz

Fig 7. Gain as a function of collector current; typical value

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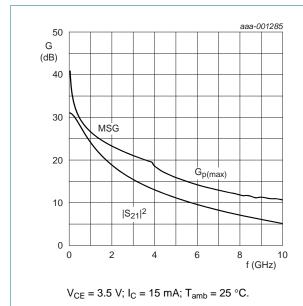


Fig 8. Gain as a function of frequency; typical values

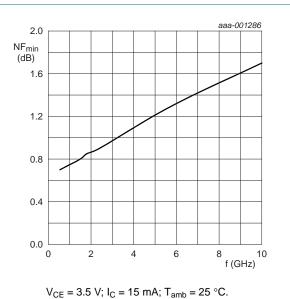


Fig 9. Minimum noise figure as a function of frequency; typical values

Package outline

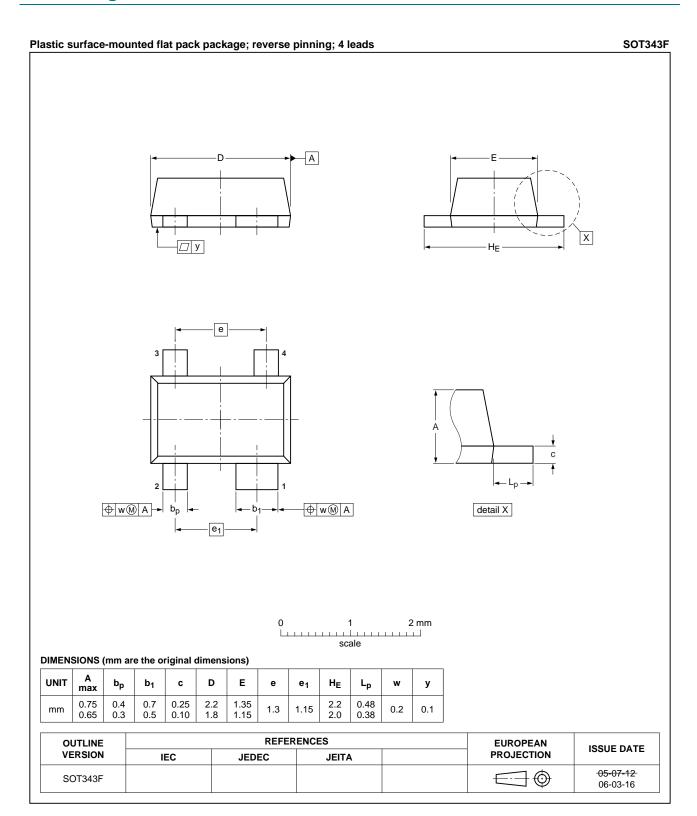


Fig 10. Package outline SOT343F

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10. Abbreviations

Table 8. Abbreviations

| Acronym | Description |
|---------|---------------------------------|
| DC | Direct Current |
| DRO | Dielectric Resonator Oscillator |
| Ku | Kurtz under |
| LNA | Low Noise Amplifier |
| LNB | Low Noise Block |
| NPN | Negative-Positive-Negative |
| RF | Radio Frequency |

11. Revision history

Table 9. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------|--------------|--|---------------|-------------|
| BFU668F v.3 | 20120124 | Product data sheet | - | BFU668F v.2 |
| Modifications: | | <u>page 2</u> : maximum value for page 5: maximum value for | . – | |
| BFU668F v.2 | 20120120 | Product data sheet | - | BFU668F v.1 |
| BFU668F v.1 | 20111108 | Product data sheet | - | - |

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|--------------------------------|-------------------|---|
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| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

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- [2] The term 'short data sheet' is explained in section "Definitions"
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